


Search Notes 	Application/Control No. 10653021	Applicant(s)/Patent Under Reexamination LUO ET AL.
	Examiner Chawan, Sheela C	Art Unit 2624

SEARCHED			
Class	Subclass	Date	Examiner
382	117,167,165,275,164,103,274,118,199,173,162,190,115,	1/22/07	SCC
348	239,241,	"	"
396	191,198,	"	"
426	72,311,620,640,641,658	"	"
382	117,274	7/16/08	SCC
ABOVE SEARCH UP- DATE		7/16/08	SCC

SEARCH NOTES		
Search Notes	Date	Examiner
EAST,US-PGPUB,USPAT,EPO,JPO,DERWENT, IBM-TDB.	1/22/07	SCC
INVENTOR NAME SEARCH.	"	"
SEARCH EAST AND OTHER DATABASE, SEE THE SEARCH HISTORY	7/16/08	SCC
382/117,275,274,118, CCLS. SEARCH US-PATENT TEXT SEARCH ONLY.	7/16/08	SCC
INTERFERENCE SEARCH	7/16/08	SCC
SEARCH IEEE OR INSPEC DATA BASE.	7/16/08	SCC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
382	117, 274	7/16/08	SCC